

COMPLIANT

HALOGEN FREE

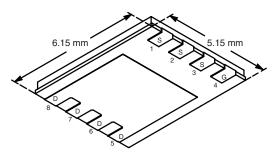


Vishay Siliconix

# N-Channel 25-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
25	0.0028 at V <sub>GS</sub> = 10 V	50 <sup>a, g</sup>	29.5 nC		
	$0.0038$ at $V_{GS} = 4.5 \text{ V}$	50 <sup>a, g</sup>			

### PowerPAK® SO-8



Bottom View

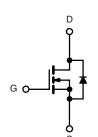
Ordering Information: SiR844DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- New MOSFET Technology Optimized for Ringing Reduction in Switching Applications
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

### APPLICATIONS

- Low-Side MOSFET
  - Server, V<sub>core</sub>
  - DC/DC



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	T <sub>A</sub> = 25 °C, unle	ss otherwise not	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	25	V	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		50 <sup>a, g</sup>		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	50 <sup>g</sup>		
Continuous Brain Current (1) = 130 G)	T <sub>A</sub> = 25 °C	טי	30 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		24 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	70	A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	50 <sup>g</sup>	1	
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	'S	4.5 <sup>b, c</sup>	1	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	40	1	
Single Pulse Avalanche Energy	L = 0.1 11111	E <sub>AS</sub>	80	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		50		
	T <sub>C</sub> = 70 °C	P <sub>D</sub>	32	w	
	T <sub>A</sub> = 25 °C	' 0	5.0 <sup>b, c</sup>	7 "	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	2.0	2.5	- C/VV	

### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (<a href="https://www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 70 °C/W.
- g. Package limited.

# SiR844DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	<u> </u>					Į.	
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		20		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.6			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.0		2.6	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		0.0022	0.0028	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.0030	0.0038		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A		50		S	
Dynamic <sup>b</sup>					l		
Input Capacitance	C <sub>iss</sub>			3215			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		800		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			475			
Total Gate Charge		V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		60	90	nC	
				29.5	44		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		7.8			
Gate-Drain Charge	Q <sub>gd</sub>			9.7			
Gate Resistance	$R_g$	f = 1 MHz	0.15	0.6	1.2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 1 $\Omega$		9	18		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 10 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		33	60		
Fall Time	t <sub>f</sub>			8	16		
Turn-On Delay Time	t <sub>d(on)</sub>			30	55		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 1 $\Omega$		21	40		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ 10 A, $\text{V}_\text{GEN}$ = 4.5 V, $\text{R}_\text{g}$ = 1 $\Omega$		39	75		
Fall Time	t <sub>f</sub>			18	35		
Drain-Source Body Diode Characteristic	cs				•		
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			50		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				70	A	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A		0.73	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/up T = 25 °C		15	30	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		13			
Reverse Recovery Rise Time	t <sub>b</sub>			12	İ	ns	

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

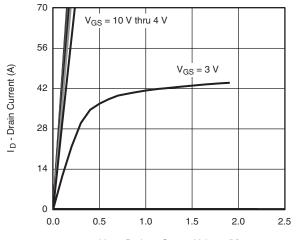
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





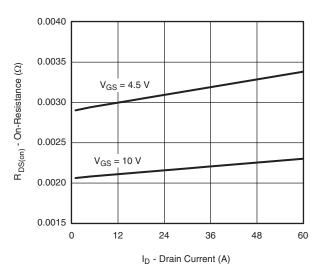
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# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

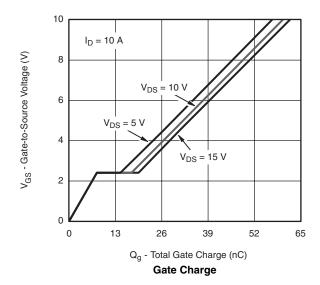


 $V_{DS}$  - Drain-to-Source Voltage (V)

### **Output Characteristics**



On-Resistance vs. Drain Current and Gate Voltage



8 T<sub>C</sub> = 25 °C
2 T<sub>C</sub> = 125 °C

10

0

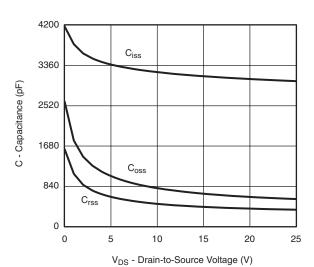
0

I<sub>D</sub> - Drain Current (A)

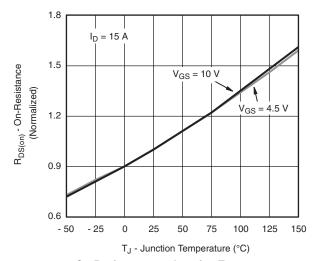
V<sub>GS</sub> - Gate-to-Source Voltage (V)

T<sub>C</sub> = - 55 °C

### **Transfer Characteristics**



Capacitance

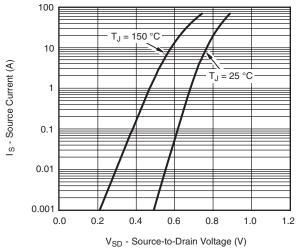


On-Resistance vs. Junction Temperature

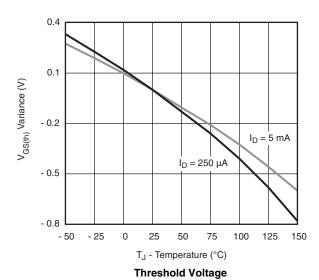
# SiR844DP

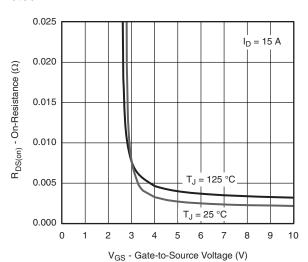
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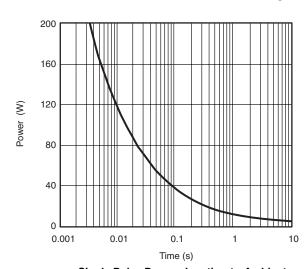


# Source-Drain Diode Forward Voltage

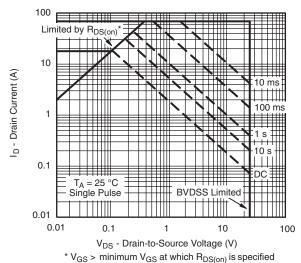




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

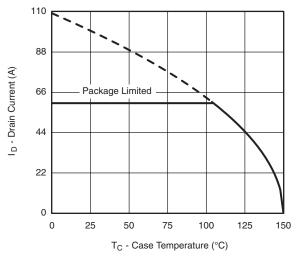


Safe Operating Area, Junction-to-Ambient

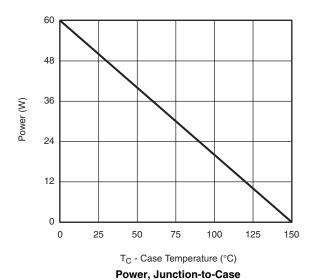


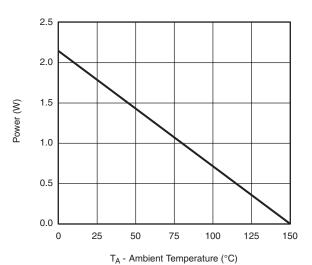
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### **Current Derating\***





Power, Junction-to-Ambient

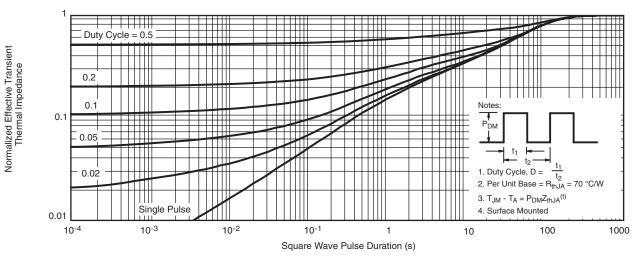
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

# SiR844DP

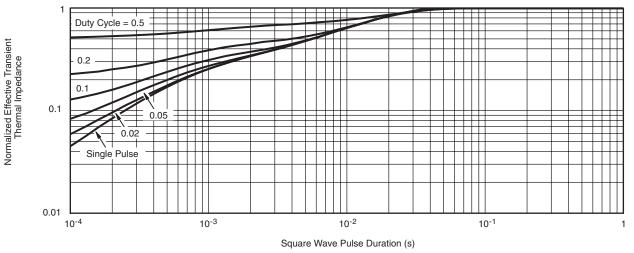
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# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg264810">www.vishay.com/ppg264810</a>.



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